## Applicant(s)/Patent Under Application/Control No. Reexamination 10/004,900 GRUBER ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 3629 Tan Dean D. Nguyen **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 705/1 US-2002/0111815 08-2002 Smith, Gordon James A US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.